











CSD19531Q5A

SLPS406B - SEPTEMBER 2013-REVISED MAY 2014

CSD19531Q5A 100 V N-Channel NexFET™ Power MOSFETs

Features

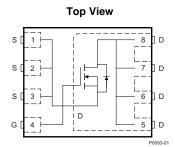
- Ultra-Low Qa and Qad
- Low Thermal Resistance
- Avalanche Rated
- Pb-Free Terminal Plating
- **RoHS Compliant**
- Halogen Free
- SON 5 mm × 6 mm Plastic Package

Applications

- Primary Side Telecom
- Secondary Side Synchronous Rectifier
- Motor Control

Description 3

This 100 V, 5.3 m Ω , SON 5 mm × 6 mm NexFETTM power MOSFET is designed to minimize losses in power conversion applications.



$R_{DS(on)}$ vs V_{GS} 20 $T_C = 25^{\circ}C, I_D = 16A$ $R_{DS(on)}$ - On-State Resistance $\,(m\Omega)\,$ 18 $T_C = 125^{\circ}C, I_D = 16A$ 16 14 12 10 8 6 4 2 0 0 8 10 12 14 18 20 V_{GS} - Gate-to- Source Voltage (V)

Product Summary

T _A = 25°C		TYPICAL VA	UNIT	
V_{DS}	Drain-to-Source Voltage	100		V
Q_g	Gate Charge Total (10 V)	37	nC	
Q_{gd}	Gate Charge Gate to Drain	6.6		nC
D	Drain to Source On Besistance	$V_{GS} = 6 V$	6.0	mΩ
R _{DS(on)}	Drain-to-Source On Resistance	V _{GS} = 10 V	5.3	mΩ
V _{GS(th)}	Threshold Voltage	2.7		٧

Ordering Information

Device	Media	Qty	Package	Ship
CSD19531Q5A	13-Inch Reel	2500	SON 5 x 6 mm	Tape and
CSD19531Q5AT	7-Inch Reel	250	Plastic Package	Reel

(1) For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

T _A = 2	5°C	VALUE	UNIT
V_{DS}	Drain-to-Source Voltage	100	٧
V_{GS}	Gate-to-Source Voltage	±20	V
	Continuous Drain Current (Package limited)	100	
I_D	Continuous Drain Current (Silicon limited), $T_C = 25^{\circ}C$		Α
Continuous Drain Current ⁽¹⁾		16	
I_{DM}	Pulsed Drain Current ⁽²⁾	337	Α
D	Power Dissipation ⁽¹⁾	3.3	W
P_D	Power Dissipation, T _C = 25°C	125	VV
T _J , T _{stg}	Operating Junction and Storage Temperature Range	-55 to 150	°C
E _{AS}	Avalanche Energy, single pulse $I_D = 60 \text{ A}, L = 0.1 \text{ mH}, R_G = 25 \Omega$	180	mJ

- (1) Typical $R_{\theta JA} = 40^{\circ} \text{C/W}$ on a 1-inch 2 , 2-oz. Cu pad on a 0.06-inch thick FR4 PCB.
- (2) Max $R_{\theta JC} = 1.0$ °C/W, pulse duration ≤ 100 µs, duty cycle $\leq 1\%$

Gate Charge

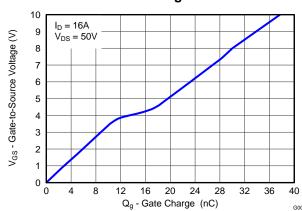




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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (January 2014) to Revision B	Page
Increased pulsed drain current to 337A	
Added line for max power dissipation with case temperature held to 25°C	
• Changed Figure 1 from a normalized R _{BJA} curve to a normalized R _{BJC} curve	4
Updated the safe operating area in Figure 10	
Changes from Original (September 2013) to Revision A	Page
Added more information to description	



5 Specifications

5.1 Electrical Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC	CHARACTERISTICS		·			
BV _{DSS}	Drain-to-Source Voltage	V _{GS} = 0 V, I _D = 250 μA	100			V
I _{DSS}	Drain-to-Source Leakage Current	V _{GS} = 0 V, V _{DS} = 80 V			1	μΑ
I _{GSS}	Gate-to-Source Leakage Current	V _{DS} = 0 V, V _{GS} = 20 V			100	nA
V _{GS(th)}	Gate-to-Source Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA	2.2	2.7	3.3	V
D	Decis to Course On Besistance	V _{GS} = 6 V, I _D = 16 A		6.0	7.8	mΩ
R _{DS(on)}	Drain-to-Source On Resistance	V _{GS} = 10 V, I _D = 16 A		5.3	6.4	mΩ
9 _{fs}	Transconductance	V _{DS} = 10 V, I _D = 16 A		82		S
DYNAM	IC CHARACTERISTICS				'	
C _{iss}	Input Capacitance			2980	3870	pF
C _{oss}	Output Capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 50 \text{ V}, f = 1 \text{ MHz}$		560	728	pF
C _{rss}	Reverse Transfer Capacitance			13.0	16.9	pF
R _G	Series Gate Resistance			1.3	2.6	Ω
Qg	Gate Charge Total (10 V)			37	48	nC
Q _{gd}	Gate Charge Gate to Drain	V 50 V 1 40 A		6.6		nC
Q _{gs}	Gate Charge Gate to Source	$V_{DS} = 50 \text{ V}, I_{D} = 16 \text{ A}$		10.5		nC
Q _{g(th)}	Gate Charge at V _{th}			7.3		nC
Q _{oss}	Output Charge	V _{DS} = 50 V, V _{GS} = 0 V		97		nC
t _{d(on)}	Turn On Delay Time			6.0		ns
t _r	Rise Time	V _{DS} = 50 V, V _{GS} = 10 V,		5.8		ns
t _{d(off)}	Turn Off Delay Time	$I_{DS} = 16 \text{ A}, R_G = 0 \Omega$		18.4		ns
t _f	Fall Time			5.2		ns
DIODE (CHARACTERISTICS				'	
V_{SD}	Diode Forward Voltage	I _{SD} = 16 A, V _{GS} = 0 V		0.8	1	V
Q _{rr}	Reverse Recovery Charge	V _{DS} = 50 V, I _F = 16 A,		226		nC
t _{rr}	Reverse Recovery Time	di/dt = 300 A/µs		148		ns

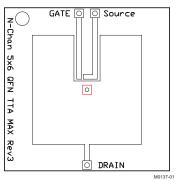
5.2 Thermal Characteristics

(T_A = 25°C unless otherwise stated)

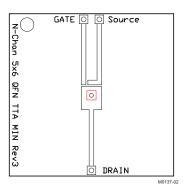
	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-Case Thermal Resistance ⁽¹⁾			1	°C/W
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance ⁽¹⁾⁽²⁾			50	C/VV

 ⁽¹⁾ R_{θJC} is determined with the device mounted on a 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu pad on a 1.5-inch x 1.5-inch (3.81-cm x 3.81-cm), 0.06-inch (1.52-mm) thick FR4 PCB. R_{θJC} is specified by design, whereas R_{θJA} is determined by the user's board design.
 (2) Device mounted on FR4 material with 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu.





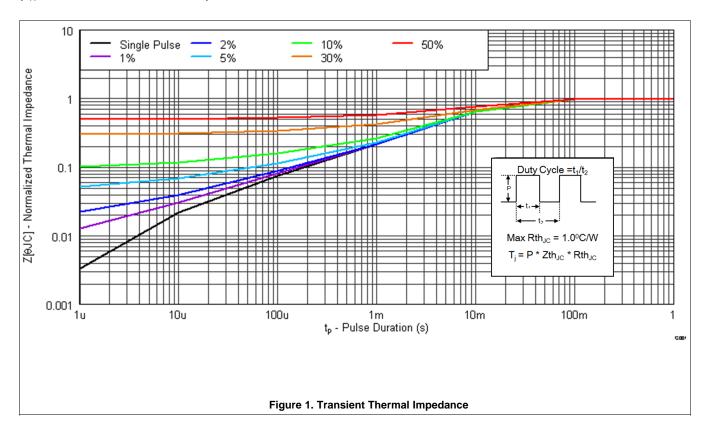
Max $R_{\theta JA} = 50^{\circ} C/W$ when mounted on 1 inch² (6.45 cm²) of 2-oz. (0.071-mm thick) Cu.



Max $R_{\theta JA} = 115^{\circ} C/W$ when mounted on a minimum pad area of 2-oz. (0.071-mm thick) Cu.

5.3 Typical MOSFET Characteristics

(T_A = 25°C unless otherwise stated)



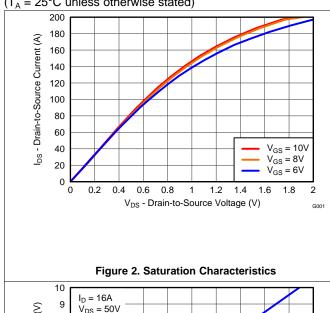
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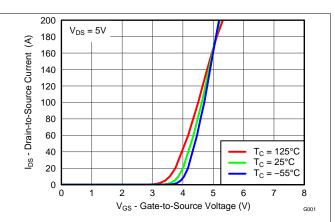
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Typical MOSFET Characteristics (continued)

(T_A = 25°C unless otherwise stated)





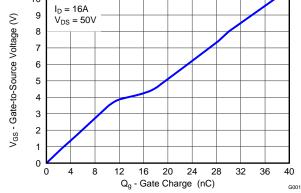


Figure 3. Transfer Characteristics

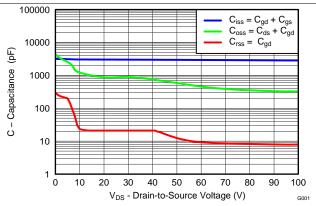


Figure 4. Gate Charge

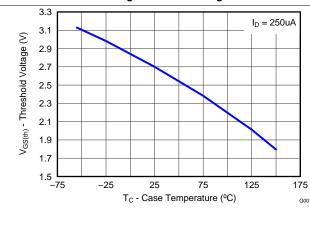


Figure 5. Capacitance

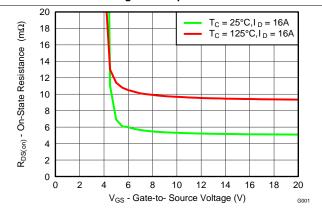


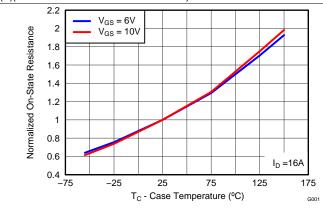
Figure 6. Threshold Voltage vs Temperature

Figure 7. On-State Resistance vs Gate-To-Source Voltage



Typical MOSFET Characteristics (continued)

(T_A = 25°C unless otherwise stated)



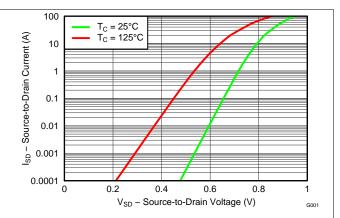


Figure 8. Normalized On-State Resistance vs Temperature

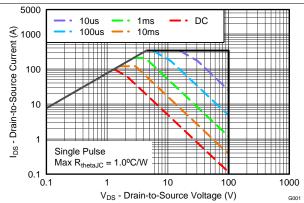


Figure 9. Typical Diode Forward Voltage

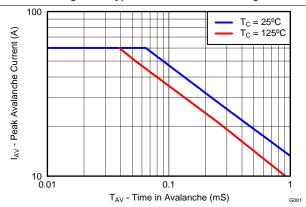


Figure 10. Maximum Safe Operating Area



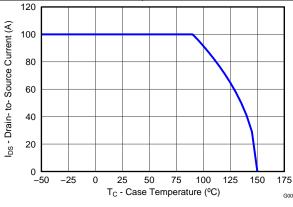


Figure 12. Maximum Drain Current vs Temperature



6 Device and Documentation Support

6.1 Trademarks

NexFET is a trademark of Texas Instruments.

6.2 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

6.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms and definitions.



7 Mechanical, Packaging, and Orderable Information

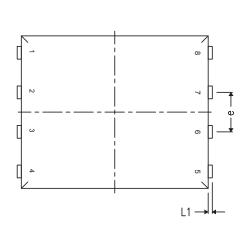
The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

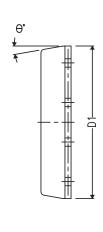
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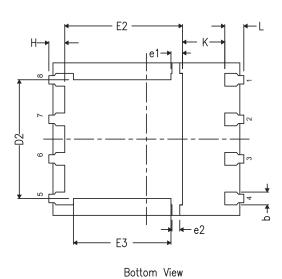


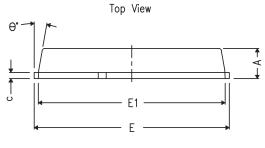
7.1 Q5A Package Dimensions





Side View





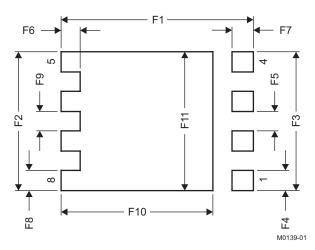
Front View

DIM		MILLIMETERS	
DIM	MIN	NOM	MAX
Α	0.90	1.00	1.10
b	0.33	0.41	0.51
С	0.20	0.25	0.34
D1	4.80	4.90	5.00
D2	3.61	3.81	4.02
E	5.90	6.00	6.10
E1	5.70	5.75	5.80
E2	3.38	3.58	3.78
E3	3.03	3.13	3.23
е	1.17	1.27	1.37
e1	0.27	0.37	0.47
e2	0.15	0.25	0.35
Н	0.41	0.56	0.71
K	1.10		
L	0.51	0.61	0.71
L1	0.06	0.13	0.20
θ	0°	_	12°

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7.2 Recommended PCB Pattern



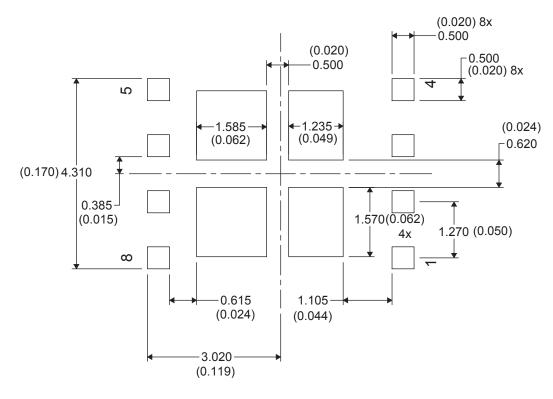
DIM	MILLIM	ETERS	INC	HES
DIM	MIN	MAX	MIN	MAX
F1	6.205	6.305	0.244	0.248
F2	4.46	4.56	0.176	0.18
F3	4.46	4.56	0.176	0.18
F4	0.65	0.7	0.026	0.028
F5	0.62	0.67	0.024	0.026
F6	0.63	0.68	0.025	0.027
F7	0.7	0.8	0.028	0.031
F8	0.65	0.7	0.026	0.028
F9	0.62	0.67	0.024	0.026
F10	4.9	5	0.193	0.197
F11	4.46	4.56	0.176	0.18

For recommended circuit layout for PCB designs, see application note SLPA005 – Reducing Ringing Through PCB Layout Techniques.

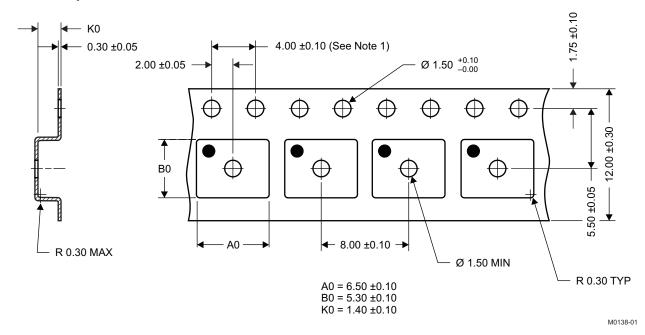
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7.3 Recommended Stencil Opening



7.4 Q5A Tape and Reel Information



Notes:

- 1. 10-sprocket hole-pitch cumulative tolerance ±0.2
- 2. Camber not to exceed 1 mm in 100 mm, noncumulative over 250 mm
- 3. Material: black static-dissipative polystyrene
- 4. All dimensions are in mm (unless otherwise specified).
- 5. A0 and B0 measured on a plane 0.3 mm above the bottom of the pocket.

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
CSD19531Q5A	Active	Production	VSONP (DQJ) 8	2500 LARGE T&R	ROHS Exempt	SN	Level-1-260C-UNLIM	-55 to 150	CSD19531
CSD19531Q5A.B	Active	Production	VSONP (DQJ) 8	2500 LARGE T&R	ROHS Exempt	SN	Level-1-260C-UNLIM	-55 to 150	CSD19531
CSD19531Q5AT	Active	Production	VSONP (DQJ) 8	250 SMALL T&R	ROHS Exempt	SN	Level-1-260C-UNLIM	-55 to 150	CSD19531
CSD19531Q5AT.B	Active	Production	VSONP (DQJ) 8	250 SMALL T&R	ROHS Exempt	SN	Level-1-260C-UNLIM	-55 to 150	CSD19531

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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